



EECE 310 - Lecture 15



Small-Signal Operation and Models

Small-Signal Operation and Models



- linear amplification can be obtained by biasing the MOSFET to operate in the saturation region and by keeping the input signal small
- we explore the small-signal operation
- MOS transistor is biased by applying a dc voltage V_{GS}
- input signal to be amplified, v_{gs} , is superimposed on the dc bias voltage V_{GS}
- output voltage is taken at the drain

The DC Bias Point



- The overdrive voltage $V_{OV} = V_{GS} V_t$ at which the MOSFET is biased to operate
- DC Voltage at drain $V_{DS} = V_{DD} R_D I_D$
- For saturation-region operation $\rightarrow V_{DS} > V_{OV}$
- To allow for the required signal swing V_{DS} has to be sufficiently greater than V_{OV}



 V_{DD}

 $\circ v_{DS}$

 v_{gs}

 v_{GS}

The Signal Current in the Drain Terminal



- Total instantaneous gate-to-source voltage will be: $v_{GS} = V_{GS} + v_{gs}$
- Total instantaneous drain current i_D,

- where
 - ▶ I_D is the DC bias current
 - i_d represents a current component that is directly proportional to the input signal v_{gs}
 - The third term is a current component that is proportional to the square of the input signal. This component is undesirable because it represents nonlinear distortion
 - ightarrow to reduce this distortion, the input signal should be kept small i.e. small signal

The Signal Current in the Drain Terminal

• So we need:

$$\frac{1}{2} \operatorname{kn} v_{gs}^2 << k_n (V_{GS} - V_t) v_{gs}$$

$$\rightarrow v_{gs} << 2 (V_{GS} - V_t) \rightarrow v_{gs} << 2V_{OV}$$

 If this small-signal condition is satisfied, we may neglect the last term

$$\rightarrow i_{D} \approx I_{D} + i_{d}$$
 where $i_{d} = k_{n} (V_{GS} - V_{t}) v_{gs}$

- ► MOSFET transconductance: $g_m \equiv i_d / v_{gs} = k_n (V_{GS} - V_t) \rightarrow g_m = k_n V_{OV}$
- It can be shown that $g_m = 2I_D/V_{OV}$ (even with channel length modulation)
- g_m is equal to the slope of the i_D-v_{GS} characteristic at the bias point,

$$g_m \equiv \left. \frac{\partial i_D}{\partial v_{GS}} \right|_{v_{GS} = V_{GS}}$$









The Voltage Gain

- $\mathbf{v}_{\mathrm{DS}} = \mathbf{V}_{\mathrm{DD}} \mathbf{R}_{\mathrm{D}}\mathbf{i}_{\mathrm{D}}$
- Under small signal condition:

$$v_{DS} = V_{DD} - R_D(I_D + i_d) \rightarrow v_{DS} = V_{DS} - R_Di_d$$

$$\rightarrow v_{ds} = -i_D R_D = -g_m v_{gs} R_D$$

$$\rightarrow A_v \equiv v_{ds} / v_{gs} = -g_m R_D$$

The minus sign indicates that the output signal v_{ds} is 180° out of phase with respect to the input signal v_{gs}



The Voltage Gain

- The input signal is assumed to have a triangular waveform
- amplitude << 2(V_{GS} V_t), the smallsignal condition (for linear operation)
- For saturation region at all times ightarrow
 - a. minimum value of v_{DS} should not fall below the corresponding value of v_{GS} by more than V_t
 - b. maximum value of v_{DS} should be smaller than V_{DD} ; (otherwise cutoff region and the peaks of the output signal waveform will be clipped off)





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Separating the DC Analysis and the Signal Analysis



Under the small-signal approximation

ightarrow signal quantities are superimposed on dc quantities

- total drain current i_D = equals the dc current I_D plus the signal current i_d
- total drain voltage $v_{DS} = V_{DS} + v_{ds} \dots$
- ➤ the analysis and design can be greatly simplified by: separating dc (bias calculations) from small-signal calculations

→

- 1. Establish a stable dc operating point and calculate all dc quantities
- 2. Perform signal analysis ignoring dc quantities





- 1. DC Analysis: Assume signal quantities are zeros Find I_D, V_{GS}, V_{DS} (Capacitors open circuits)
- 2. Find g_m
- Signal Analysis: Assume DC quantities are zeros DC Voltage supplies are short circuits – DC current sources are open circuits – Capacitors are short circuits
- 3.5 Replace MOSFETs by small signal Model
- 4. Find i_d and other quantities
- 5. $i_D = I_D + i_d$

Small-Signal Equivalent-Circuit Models



From a signal point of view, the FET behaves as a voltage-controlled current source



Figure 5.37 Small-signal models for the MOSFET: (a) neglecting the dependence of i_D on v_{DS} in saturation (the channel-length modulation effect); and (b) including the effect of channel-length modulation, modeled by output resistance $r_o = |V_A|/I_D$.

- where $V_A = I/\lambda$ is a MOSFET parameter proportional to the channel length
- Voltage gain: $A_v \equiv v_{ds} / v_{gs} = -g_m (R_D | | r_o)$
- $g_m = 2I_D/V_{OV}$



Analyze this amplifier circuit to determine:

- small-signal voltage gain
- input resistance
- largest allowable input signal
 Given:

 $Vt = 1.5 V; k'_{n}(VV/L)=0.25 mA/V_{2};$ $V_{A} = 50 V$

Assume the coupling capacitors to be sufficiently large so as to act as short circuits at the signal frequencies of interest.



Example

Step 1: DC Analysis

- Determine the dc operating point
- eliminate the input signal v_i ,
- Open circuit the two coupling capacitors
- $I_{G}=0 \rightarrow V_{GS}=V_{DS}=V_{DD}-R_{D}I_{D} \rightarrow I_{D}=(V_{DD}-V_{DS})/R_{D}$
- SAT: $I_D = \frac{1}{2} * k_n (V_{GS} V_t)^2 (1 + \lambda V_{DS})$
- Solving the two equations:
- $I_D = 1.06 \text{mA} \text{ and } V_{DS} = V_{GS} = 4.4 \text{ V}$
- And V_{ov} = 4.4 1.5 = 2.9 V





Example



- Step 2: small-signal analysis
- replace coupling capacitors
 with short circuits
- Replace DC voltage
 supply with a short circuit
 to ground.
- $g_m = k_n V_{OV} = 0.25 \times 2.9 = 0.725 \text{ mA/V}$
- $r_o = V_A / I_D = 50 / 1.06 = 47 K \Omega$





 $(i_i - g_m v_{gs})$

 R'_{τ}

U,

 $R'_{I} = R_{I} || R_{D} || r_{o}$

 R_G

 $g_m v_{gs}$

(d)

Example

- $R'_{L} = R_{L} ||R_{D}||r_{o} = 10||10||47 = 4.52k\Omega$
- $v_o = (i_i g_m v_{gs}) R'_L$
- $i_i = (v_{gs} v_o)/R_G$
- $\rightarrow A_v = v_o / v_i =$
- $A_v = -g_m R'_L [1 (1/g_m R_G)/(1 + (R'_L/R_G))]$
- Since R_G is very large

$$A_v \approx -g_m R'_L = -3.3 V/V$$

•
$$R_{in} = v_i / i_i = v_{gs} / i_i = R_G / (I + g_m R'_L) = 2.33 M\Omega$$

▶ Largest allowable input signal is constrained by the need to keep the transistor in saturation at all times → $v_{DS} \ge v_{GS} - V_t \rightarrow v_{DSmin} = v_{GSmax} - V_t$

 v_i

- ► $\rightarrow V_{DS} |A_v| v_i = V_{GS} + v_i V_t \text{ But } V_{DS} = V_{GS} \rightarrow v_i = V_t/(|A_v|+1) \rightarrow v_i = 1.5/(3.3+1) = 0.35V$
- Check $V_{GS} > V_t \rightarrow 4.4 \pm 0.35 > 1.5 \rightarrow$ we will never reach cutoff region.

 $R_{\text{in}} = \frac{v_i}{i}$

Exact Calculations



- Including the Channel Length Modulation and the Body Effect
- $i_D = f(v_{GS}, v_{DS}, v_{BS}) = g_m v_{gs} + g_{ds} v_{ds} + g_{mb} v_{bs}$ • $g_{mb} = Xg_m$ where $X = \frac{\delta}{2\sqrt{|-2\phi_F + V_{SB}|}}$



The T Equivalent-Circuit Model

All the previously discussed models are referred to as $\pi - Model$



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Figure 5.40 Development of the T equivalent-circuit model for the MOSFET. For simplicity, r_o has been omitted; however, it may be added between D and S in the T model of (d).

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The T Equivalent-Circuit Model





Figure 5.41 (a) The T model of the MOSFET augmented with the drain-to-source resistance r_o . (b) An alternative representation of the T model.



Small Signal Circuits





Thank you !